To be submitted to XXIIth International Symposia on Discharges and Electrical Insulation in Vacuum Matsue, Japan September 25-29, 2006

Fourier Analysis of Fast Vacuum Arc Parameters

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Abstract November 24, 2005

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This work was supported by the U.S. Department of Energy, Initiatives of Proliferation Prevention, project IPP-LBNL-T2-196, under Contract No. DE-AC02-05CH11231, and by the Russian Foundation for Basic Research Grant # 05-02-16256.

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Vacuum arcs are known for their noisy character: all parameters show more-or-less rapid

fluctuations. This is of particular concern to those who would like to utilize the

exceptional properties of the vacuum arc plasma in ion sources other devices. Among

these properties are the very high degree of ionization and the presence of multiply

ionized species. The rapid fluctuations are known to be ultimately caused by the

explosive nature of the perpetual spot ignition and plasma production. In this

contribution, we present a systematic application of Fast Fourier Transform to fluctuating

parameters such as voltage and current. New possibilities have arisen with the advent of

fast digital oscilloscopes and relatively low cost computation of large amounts of data.

We show that most fluctuations indicate fractal character, i.e. the spectral power scales

with a power law in log-log presentation. In the high frequency region (typically 50 MHz

and faster), the fractal behavior seems to be cut off, which might be associated with

approaching the region of individual explosive processes, also known as ectons.

List of Key Words: Vacuum Arcs, Cathode Spots, Fourier Analysis, Fractals, Ectons

Proposed Session: B1

Preferred Presentation: Oral, Speaker: A. Anders

Equipment: computer projector